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Jameco Part Number 47010

SYNCHRONOUS PRESETTABLE UP/DOWN DECADE COUNTER

DESCRIPTION

The M74LS192P is a semiconductor integrated circuit containing a synchronous decade up/down counter function with direct reset and preset inputs.

FEATURES

- Special up count, down count clock inputs
- Asynchronous preset input provided
- Direct reset input provided
- Easy cascade connection possible
- High-speed counting ($f_{max} = 38\text{MHz}$ typical)
- Wide operating temperature range ($T_a = -20 \sim +75^\circ\text{C}$)

APPLICATION

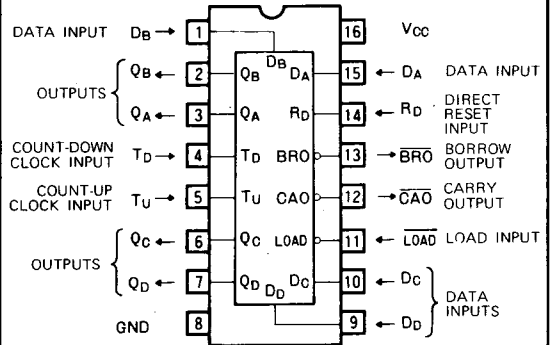
General purpose, for use in industrial and consumer equipment.

FUNCTIONAL DESCRIPTION

This device comes with special count-up clock input T_U and count-down clock input T_D used independently for count-up and count-down applications. For count-up, the number of count pulses appears as a BCD code in outputs Q_A , Q_B , Q_C and Q_D in synchronization with the count pulses by setting load input \overline{LOAD} and T_D high, applying the count pulses to T_U while for count-down, \overline{LOAD} and T_U are set high and the count pulses are applied to T_D . Counting is performed when T_U or T_D changes from low to high.

Presetting is performed independently of the count pulse. When data are applied to data inputs D_A , D_B , D_C and D_D and \overline{LOAD} is set low, the D_A , D_B , D_C and D_D signals appear in the Q_A , Q_B , Q_C and Q_D outputs, respectively, regardless of the status of the T_U and T_D signals, thereby presetting the counter. Counting proceeds as per the status

PIN CONFIGURATION (TOP VIEW)



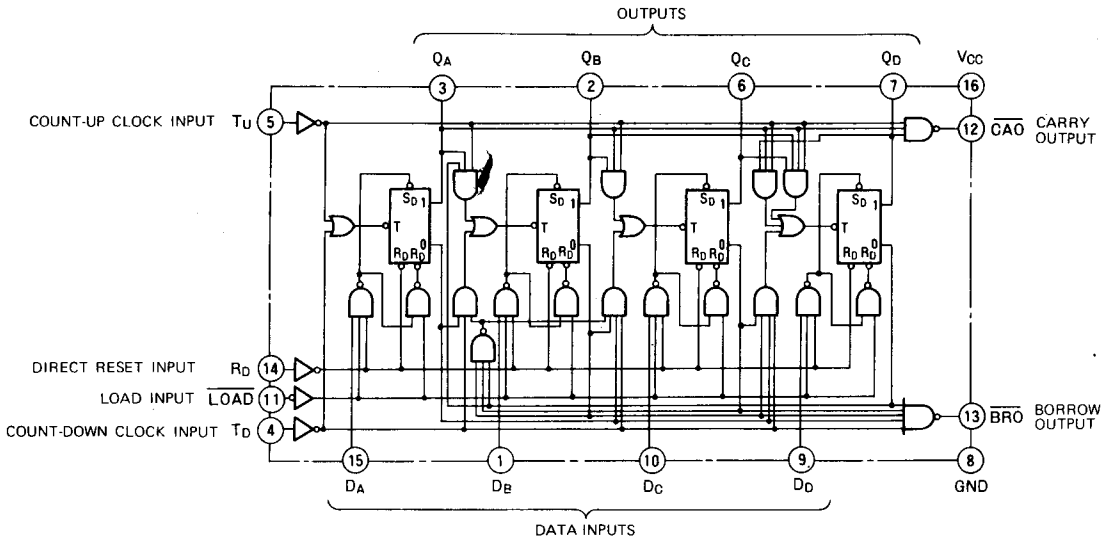
Outline 16P4

transition diagram with presetting to a numerical value of 10 or more.

Reset can be performed by setting the direct reset input R_D high which sets $Q_A = Q_B = Q_C = Q_D$ low irrespective of the status of the other inputs.

Low appears in the carry output \overline{CAO} during count-up when 9 appears in Q_A , Q_B , Q_C and Q_D and when T_U is low while low appears in output \overline{BRO} when 0 appears in the outputs \overline{CAO} and \overline{BRO} should be connected to the next stage T_U and T_D for counter cascade connection. (Refer to the application examples.)

BLOCK DIAGRAM



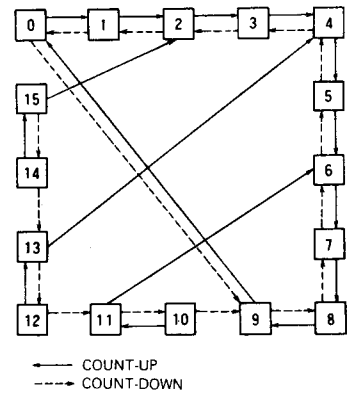
SYNCHRONOUS PRESETTABLE UP/DOWN DECADE COUNTER

FUNCTION TABLE (Note 1)

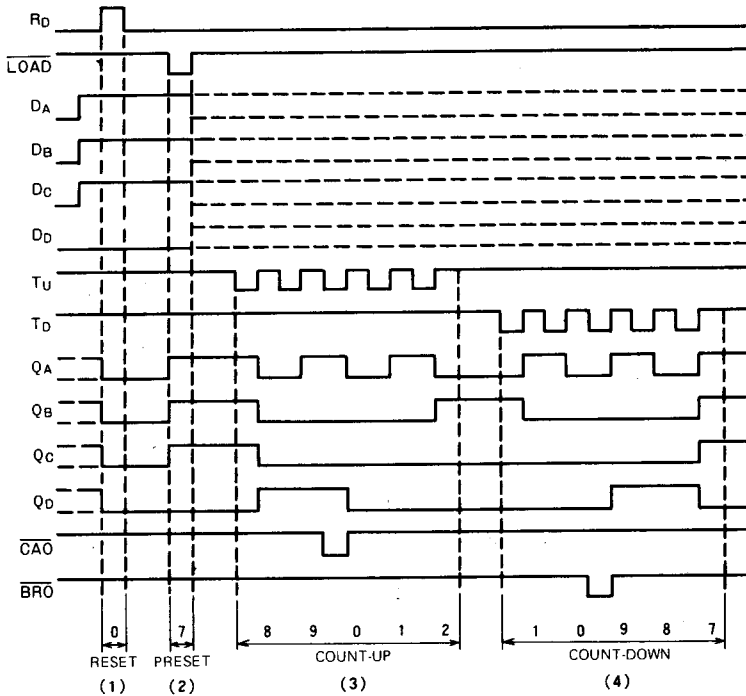
R _D	LOAD	T _U	T _D	Q _A	Q _B	Q _C	Q _D	CAO	BR0
H	X	X	X	L	L	L	L	H	H*
L	L	X	X	D _A	D _B	D _C	D _D	H*	H*
L	H	H	H	Inhibit				H*	H*
L	H	↑	H	Count-up				H*	H*
L	H	H	↑	Count-down				H*	H*

Note 1. ↑ : Transition from low to high
 * : Normally high but low appears in accordance with the following logical expressions
 $CAO = Q_A \cdot Q_D \cdot T_U$ Count-up
 $BR0 = Q_A \cdot Q_B \cdot Q_C \cdot Q_D \cdot T_D$ Count-down
 X : Irrelevant

STATE DIAGRAM



OPERATION TIMING DIAGRAM



Details of timing diagram
 (1) Reset
 (2) Preset to 7
 (3) Count-up 8, 9, 0, 1, 2
 (4) Count-down 1, 0, 9, 8, 7

ABSOLUTE MAXIMUM RATINGS (T_a = -20 ~ +75°C, unless otherwise noted)

Symbol	Parameter	Conditions	Limits	Unit
V _{CC}	Supply voltage		-0.5 ~ +7	V
V _I	Input voltage		-0.5 ~ +15	V
V _O	Output voltage	High-level state	-0.5 ~ V _{CC}	V
T _{opr}	Operating free-air ambient temperature range		-20 ~ +75	°C
T _{stg}	Storage temperature range		-65 ~ +150	°C

SYNCHRONOUS PRESETTABLE UP/DOWN DECADE COUNTER

RECOMMENDED OPERATING CONDITIONS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter		Limits			Unit
			Min	Typ	Max	
V_{CC}	Supply voltage		4.75	5	5.25	V
I_{OH}	High-level output current	$V_{OH} \geq 2.7\text{V}$	0		-400	μA
I_{OL}	Low-level output current	$V_{OL} \leq 0.4\text{V}$	0		4	mA
		$V_{OL} \leq 0.5\text{V}$	0		8	mA

ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +75^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit	
			Min	Typ *	Max		
V_{IH}	High-level input voltage		2			V	
V_{IL}	Low-level input voltage				0.8	V	
V_{IC}	Input clamp voltage	$V_{CC} = 4.75\text{V}$, $I_{IC} = -18\text{mA}$			-1.5	V	
V_{OH}	High-level output voltage	$V_{CC} = 4.75\text{V}$, $V_I = 0.8\text{V}$ $V_I = 2\text{V}$, $I_{OH} = -400\mu\text{A}$	2.7	3.4		V	
V_{OL}	Low-level output voltage	$V_{CC} = 4.75\text{V}$			0.25	0.4	V
		$V_I = 0.8\text{V}$, $V_I = 2\text{V}$			0.35	0.5	V
I_{IH}	High-level input current	$V_{CC} = 5.25\text{V}$, $V_I = 2.7\text{V}$				20	μA
		$V_{CC} = 5.25\text{V}$, $V_I = 10\text{V}$				0.1	mA
I_{IL}	Low-level input current	$V_{CC} = 5.25\text{V}$, $V_I = 0.4\text{V}$				-0.4	mA
I_{OS}	Short-circuit output current (Note 2)	$V_{CC} = 5.25\text{V}$, $V_O = 0\text{V}$	-20			-100	mA
I_{CC}	Supply current	$V_{CC} = 5.25\text{V}$ (Note 3)		19	34	mA	

* : All typical values are at $V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$.

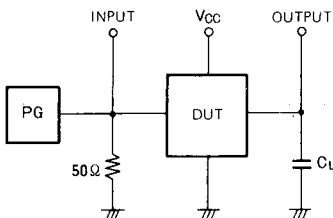
Note 2. All measurements should be done quickly and not more than one output should be shorted at a time.

Note 3. I_{CC} is measured with R_D and $\overline{\text{LOAD}}$ at 0V and T_U , T_D , $D_A \sim D_D$ at 4.5V

SWITCHING CHARACTERISTICS ($V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
f_{max}	Maximum clock frequency	$C_L = 15\text{pF}$ (Note 4)	25	38		MHz
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input T_U to output $CA0$			7	26	ns
t_{PHL}	High-to-low-level output propagation time, from input T_U to output $CA0$			14	24	ns
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input T_D to output \overline{BRO}			7	24	ns
t_{PHL}	High-to-low-level output propagation time, from input T_D to output \overline{BRO}			19	24	ns
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input T_U , T_D to outputs QA , QB , QC , QD			20	38	ns
t_{PHL}	High-to-low-level output propagation time, from input T_U , T_D to outputs QA , QB , QC , QD			17	47	ns
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input $\overline{\text{LOAD}}$ to outputs QA , QB , QC , QD			24	40	ns
t_{PHL}	High-to-low-level output propagation time, from input $\overline{\text{LOAD}}$ to outputs QA , QB , QC , QD			20	40	ns
t_{PHL}	High-to-low-level output propagation time, from input R_D to outputs QA , QB , QC , QD				12	35

Note 4. Measurement circuit



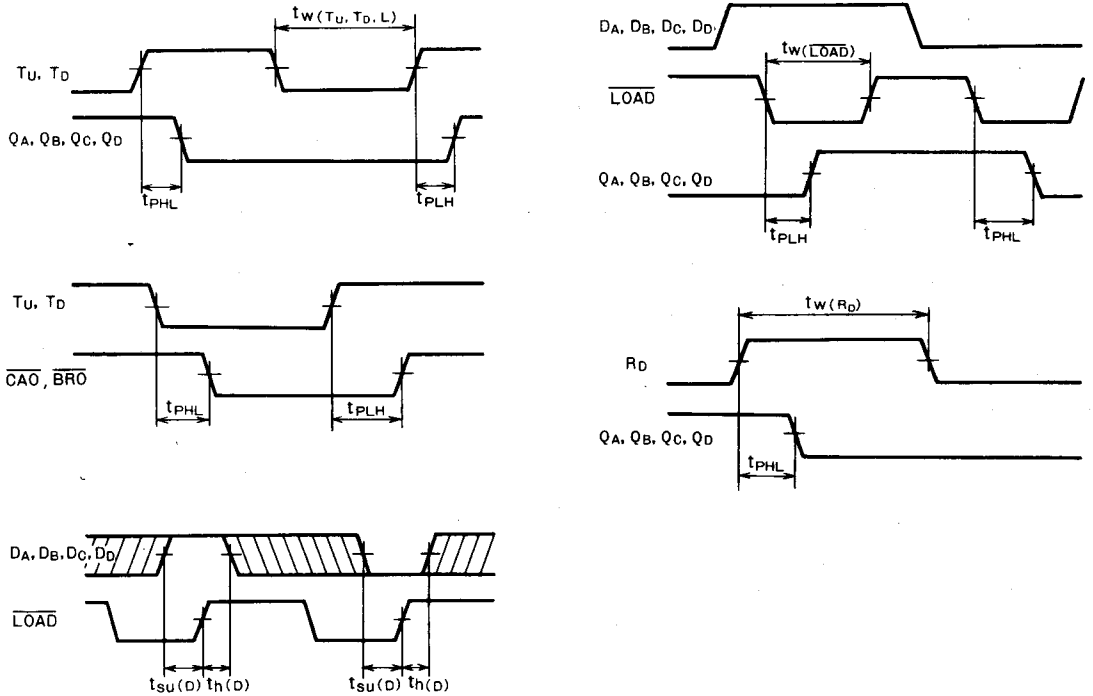
- (1) The pulse generator (PG) has the following characteristics:
PRR = 1MHz, $t_r = 6\text{ns}$, $t_f = 6\text{ns}$, $t_w = 500\text{ns}$,
 $V_p = 3\text{V}_{p.p.}$, $Z_o = 50\Omega$.
- (2) C_L includes probe and jig capacitance

SYNCHRONOUS PRESETTABLE UP/DOWN DECADE COUNTER

TIMING REQUIREMENTS ($V_{CC} = 5V$, $T_a = 25^\circ C$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$t_w(T_{U,L})$	Clock input T_U low pulse width		20	14		ns
$t_w(T_{D,L})$	Clock input T_D low pulse width		20	18		ns
$t_w(L_{O\bar{A}D})$	Load $L_{O\bar{A}D}$ pulse width		20	11		ns
$t_w(R_D)$	Direct reset R_D pulse width		20	4		ns
$t_{su}(D)$	Setup time $D_A \sim D_D$ to $L_{O\bar{A}D}$		20	4		ns
$t_h(D)$	Hold time $D_A \sim D_D$ to $L_{O\bar{A}D}$		5	-3		ns

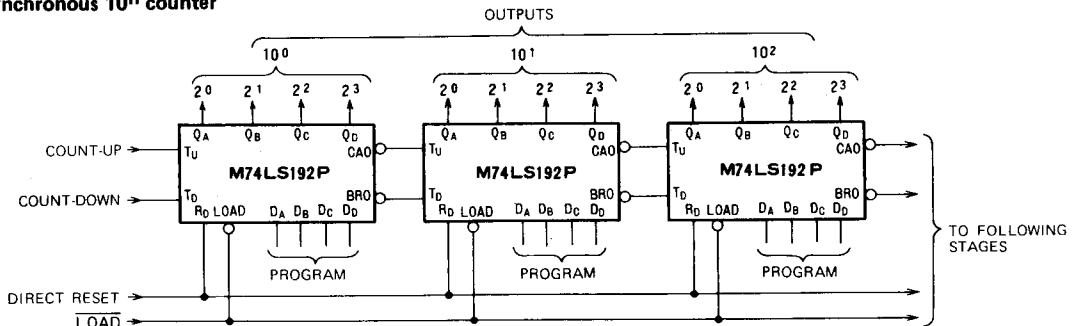
TIMING DIAGRAM (Reference level = 1.3V)



Note 5. The shaded areas indicate when the input is permitted to change for predictable output performance.

APPLICATION EXAMPLE

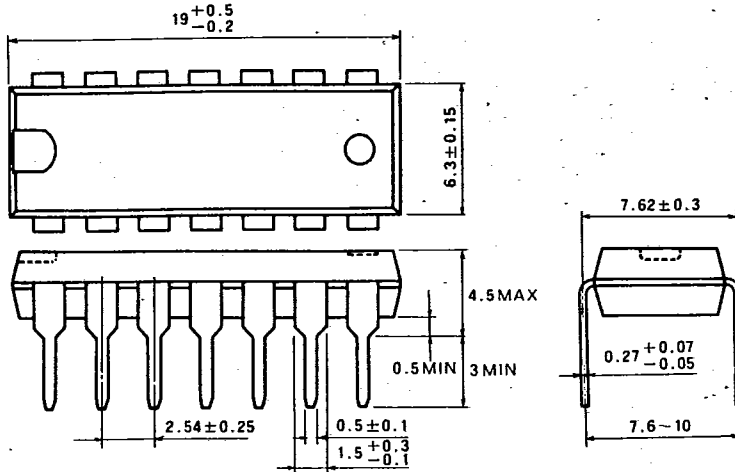
Asynchronous 10^N counter



T-90-20

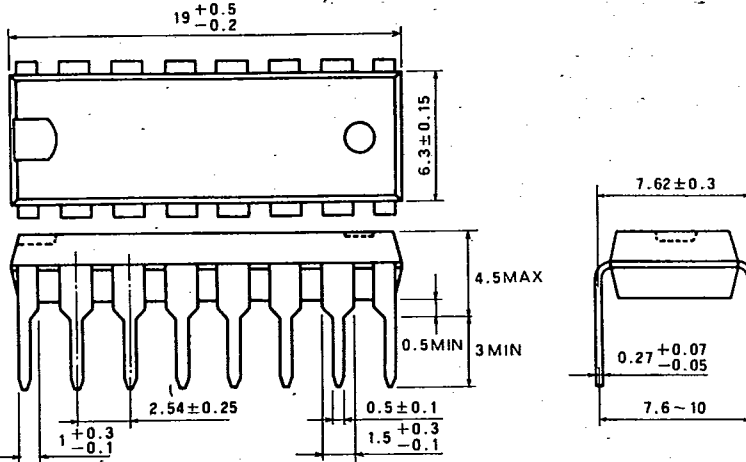
TYPE 14P4 14-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 16P4 16-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 20P4 20-PIN MOLDED PLASTIC DIL

Dimension in mm

